

September 2007

FDD8453LZ

N-Channel PowerTrench® MOSFET 40V, 50A, 6.7m Ω

Features

- Max $r_{DS(on)} = 6.7 \text{m}\Omega$ at $V_{GS} = 10 \text{V}$, $I_D = 15 \text{A}$
- Max $r_{DS(on)} = 8.7 \text{m}\Omega$ at $V_{GS} = 4.5 \text{V}$, $I_D = 13 \text{A}$
- HBM ESD protection level >7kV typical (Note 4)
- RoHS Compliant

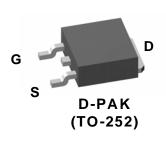
General Description

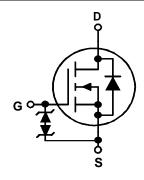
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and switching loss. G-S zener has been added to enhance ESD voltage level.

Applications

- Inverter
- Synchronous Rectifier







MOSFET Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V_{DS}	Drain to Source Voltage			40	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25°C		50	
I _D	-Continuous (Silicon limited)	T _C = 25°C		75	^
	-Continuous	T _A = 25°C	(Note 1a)	16.4	Α
	-Pulsed			100	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	253	mJ
Б	Power Dissipation	T _C = 25°C		65	10/
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	3.1	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.9	°C/W
R _{e.IA}	Thermal Resistance, Junction to Ambient	(Note 1a)	40	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8453LZ	FDD8453LZ	D-PAK (TO-252)	13"	12mm	2500 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		36		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32V, V_{GS} = 0V$			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±10	μА

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25°C		-6.0		mV/°C
		V _{GS} = 10V, I _D = 15A		5.8	6.7	
rno()	Static Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 13A$		6.8	8.7	mΩ
r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 15A,$ $T_J = 125^{\circ}C$		9.1	10.6	11122	
9 _{FS}	Forward Transconductance	$V_{DS} = 5V, I_{D} = 15A$		77		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 20V V 0V		2640	3515	pF
C _{oss}	Output Capacitance	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1MHz		320	425	pF
C _{rss}	Reverse Transfer Capacitance			190	285	pF
R_g	Gate Resistance	f = 1MHz		2.3		Ω

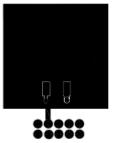
Switching Characteristics

t _{d(on)}	Turn-On Delay Time	$V_{DD} = 20V, I_D = 15A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$		11	19	ns
t _r	Rise Time			6	12	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10V, K _{GEN}	= 075	37	58	ns
t _f	Fall Time			5	10	ns
Q_{g}	Total Gate Charge	$V_{GS} = 0V \text{ to } 10V$		46	64	nC
Q_{g}	Total Gate Charge	$V_{GS} = 0V \text{ to } 5V$	$V_{DD} = 20V,$ $I_{D} = 15A$	24	33	nC
Q_{gs}	Gate to Source Charge		ID = IOA	7		nC
Q_{gd}	Gate to Drain "Miller" Charge			8		nC

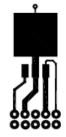
Drain-Source Diode Characteristics

1705 Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.0A$ (Note 2)		0.7	1.2	V	
	$V_{GS} = 0V, I_{S} = 15A$ (Note 2)		8.0	1.3	V	
t _{rr}	Reverse Recovery Time	-I _E = 15A, di/dt = 100A/μs		25	40	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 15A$, $d/dt = 100A/\mu S$		20	32	nC

R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.



a) 40°C/W when mounted on a 1 in² pad of 2 oz copper



b) 96°C/W when mounted on a minimum pad.

- Pulse Test: Pulse Width < 300µs, Duty cycle < 2.0%.
 Starting T_J = 25°C, L = 3mH, I_{AS} = 13A, V_{DD} = 40V, V_{GS} = 10V.
 The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

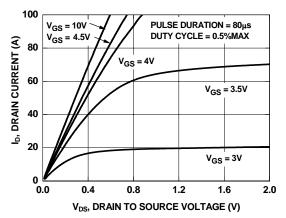


Figure 1. On-Region Characteristics

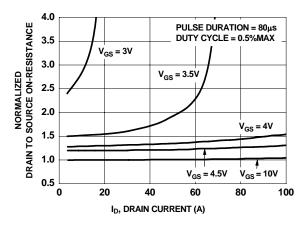


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

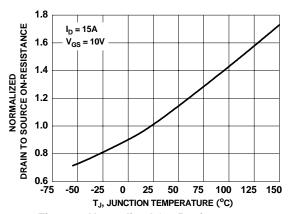


Figure 3. Normalized On-Resistance vs Junction Temperature

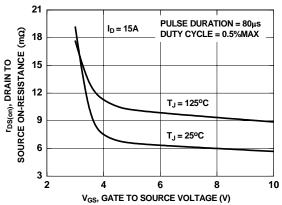


Figure 4. On-Resistance vs Gate to Source Voltage

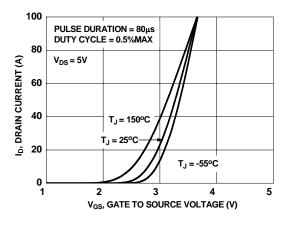


Figure 5. Transfer Characteristics

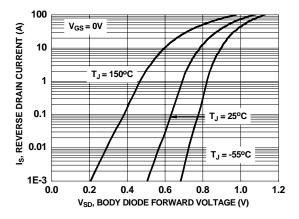


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

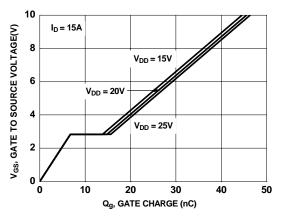


Figure 7. Gate Charge Characteristics

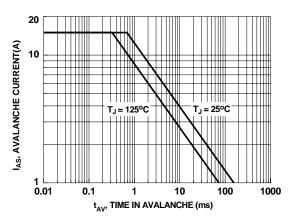


Figure 9. Unclamped Inductive Switching Capability

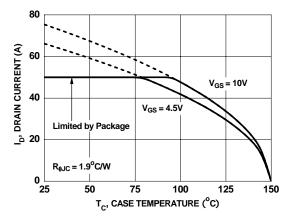


Figure 11. Maximum Continuous Drain Current vs Ambient Temperature

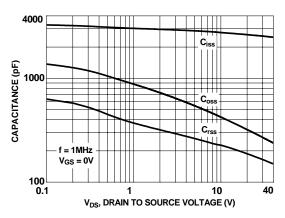


Figure 8. Capacitance vs Drain to Source Voltage

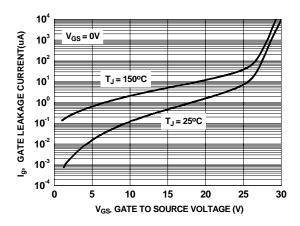


Figure 10. Gate Leakage Current vs Gate to Source Voltage

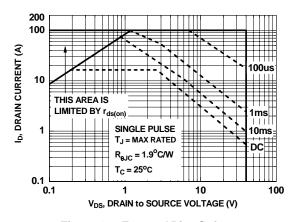


Figure 12. Forward Bias Safe Operating Area

Typical Characteristics T_J = 25°C unless otherwise noted

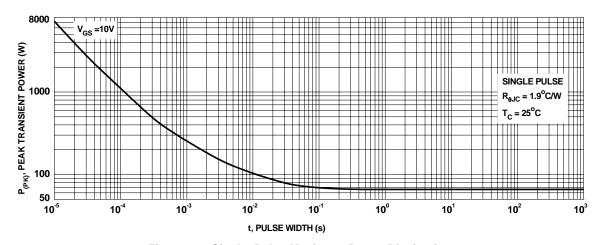


Figure 13. Single Pulse Maximum Power Dissipation

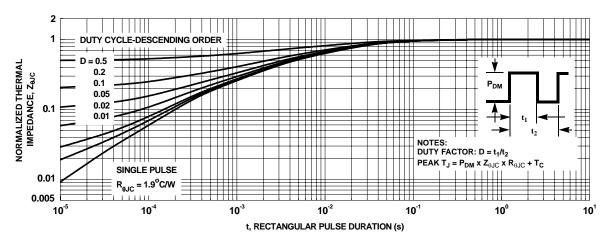


Figure 14. Transient Thermal Response Curve

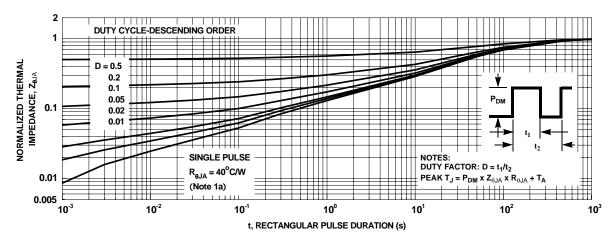


Figure 15. Transient Thermal Response Curve

Typical Characteristics T_J = 25°C unless otherwise noted

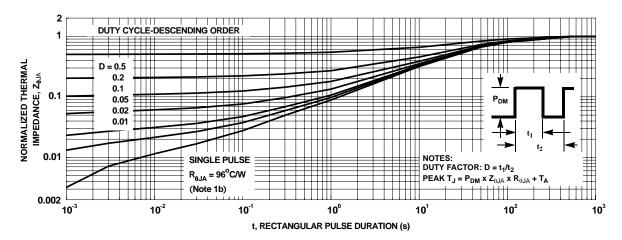


Figure 16. Transient Thermal Response Curve



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